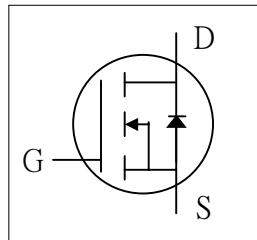
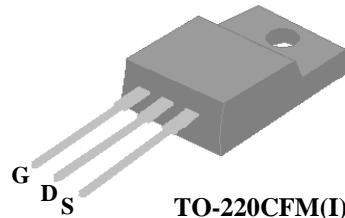




- ▼ 100% Avalanche Test
- ▼ Fast Switching Characteristic
- ▼ Simple Drive Requirement



$BV_{DSS}$	700V
$R_{DS(ON)}$	2.4Ω
$I_D$	4A



## Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220CFM package is widely preferred for commercial-industrial applications. The device is suited for switch mode power supplies, DC-AC converters and high current high speed switching circuits.

## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	700	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	4	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	2.5	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	15	A
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation	33	W
	Linear Derating Factor	0.26	W/ $^\circ\text{C}$
$E_{AS}$	Single Pulse Avalanche Energy <sup>2</sup>	8	mJ
$I_{AR}$	Avalanche Current	4	A
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

## Thermal Data

Symbol	Parameter	Value	Units
$R_{thj-c}$	Maximum Thermal Resistance, Junction-case	3.8	$^\circ\text{C}/\text{W}$
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient	65	$^\circ\text{C}/\text{W}$



## Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_{\text{D}}=1\text{mA}$	700	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_{\text{D}}=1\text{mA}$	-	0.6	-	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance <sup>3</sup>	$V_{\text{GS}}=10\text{V}$ , $I_{\text{D}}=2\text{A}$	-	-	2.4	$\Omega$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_{\text{D}}=250\text{\mu A}$	2	-	4	V
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=10\text{V}$ , $I_{\text{D}}=2\text{A}$	-	2.5	-	S
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=600\text{V}$ , $V_{\text{GS}}=0\text{V}$	-	-	10	$\text{\mu A}$
	Drain-Source Leakage Current ( $T_j=125^\circ\text{C}$ )	$V_{\text{DS}}=480\text{V}$ , $V_{\text{GS}}=0\text{V}$	-	-	500	$\text{\mu A}$
$I_{\text{GSS}}$	Gate-Source Leakage	$V_{\text{GS}}=\pm 30\text{V}$ , $V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
$Q_g$	Total Gate Charge <sup>3</sup>	$I_{\text{D}}=4\text{A}$	-	16.7	-	nC
$Q_{\text{gs}}$	Gate-Source Charge	$V_{\text{DS}}=480\text{V}$	-	4.1	-	nC
$Q_{\text{gd}}$	Gate-Drain ("Miller") Charge	$V_{\text{GS}}=10\text{V}$	-	4.9	-	nC
$t_{\text{d}(\text{on})}$	Turn-on Delay Time <sup>3</sup>	$V_{\text{DD}}=300\text{V}$	-	11	-	ns
$t_r$	Rise Time	$I_{\text{D}}=4\text{A}$	-	8.3	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time	$R_G=10\Omega$ , $V_{\text{GS}}=10\text{V}$	-	23.8	-	ns
$t_f$	Fall Time	$R_D=75\Omega$	-	8.2	-	ns
$C_{\text{iss}}$	Input Capacitance	$V_{\text{GS}}=0\text{V}$	-	950	-	pF
$C_{\text{oss}}$	Output Capacitance	$V_{\text{DS}}=25\text{V}$	-	65	-	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance	f=1.0MHz	-	6	-	pF

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$I_s$	Continuous Source Current ( Body Diode )	$V_D=V_G=0\text{V}$ , $V_S=1.5\text{V}$	-	-	4	A
$I_{\text{SM}}$	Pulsed Source Current ( Body Diode ) <sup>1</sup>		-	-	15	A
$V_{\text{SD}}$	Forward On Voltage <sup>3</sup>	$T_j=25^\circ\text{C}$ , $I_s=4\text{A}$ , $V_{\text{GS}}=0\text{V}$	-	-	1.5	V

### Notes:

- 1.Pulse width limited by max. junction temperature
- 2.Starting  $T_j=25^\circ\text{C}$  ,  $V_{\text{DD}}=50\text{V}$  ,  $L=1\text{mH}$  ,  $R_G=25\Omega$  ,  $I_{\text{AS}}=4\text{A}$ .
- 3.Pulse test

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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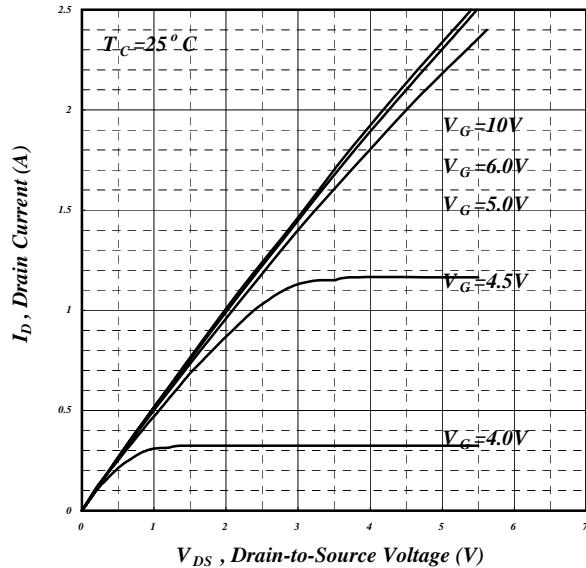


Fig 1. Typical Output Characteristics

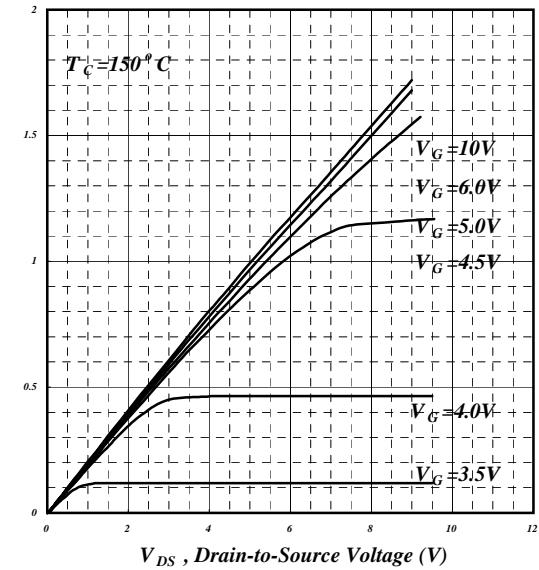


Fig 2. Typical Output Characteristics

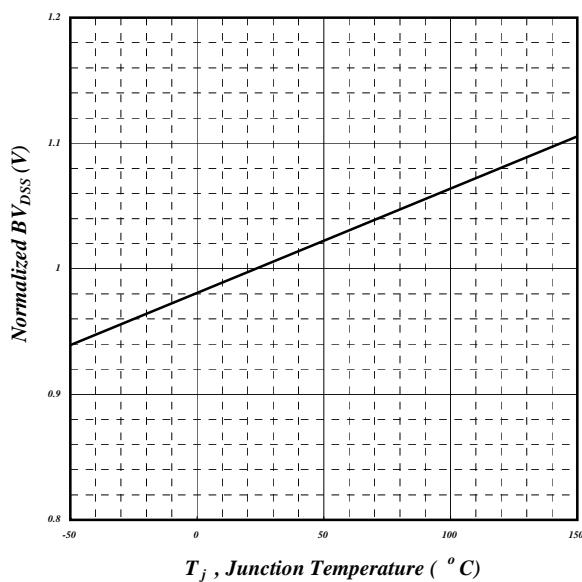
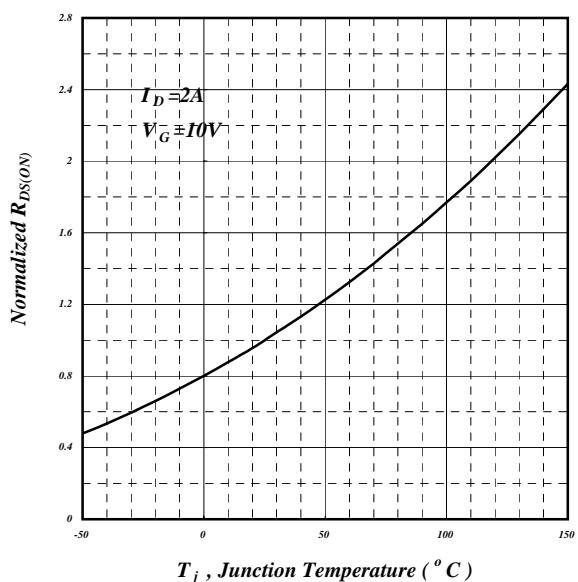
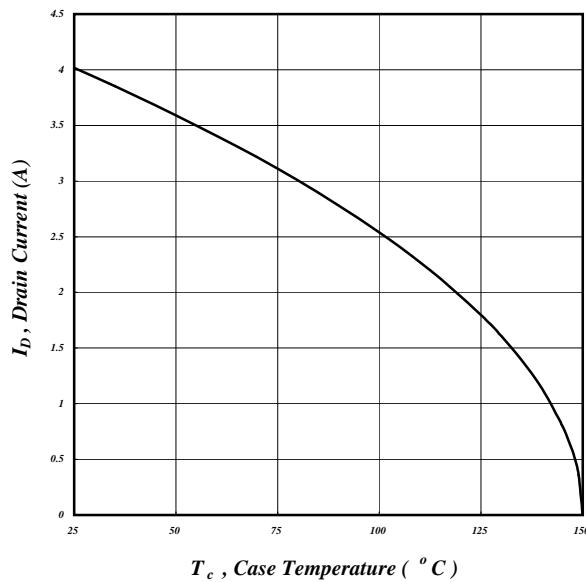
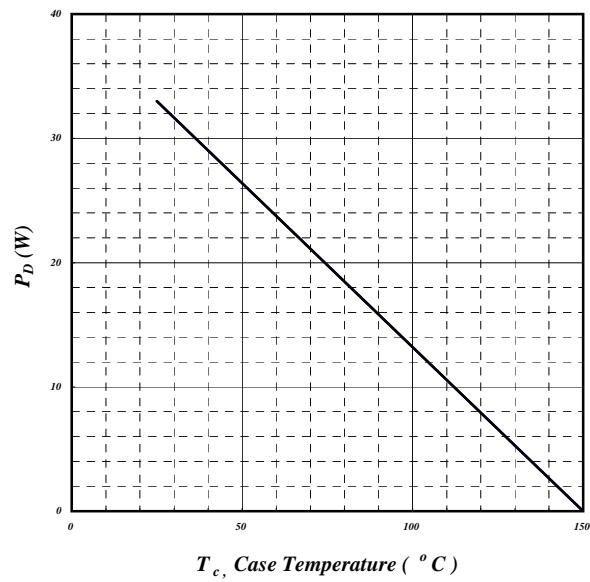
Fig 3. Normalized  $BV_{DSS}$  v.s. Junction Temperature

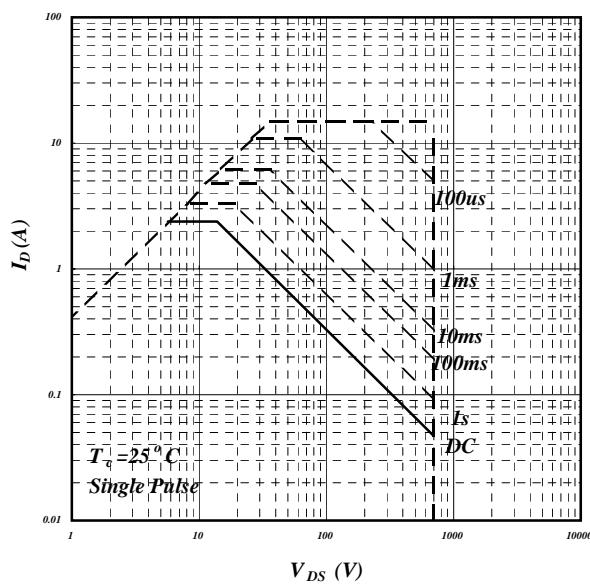
Fig 4. Normalized On-Resistance v.s. Junction Temperature



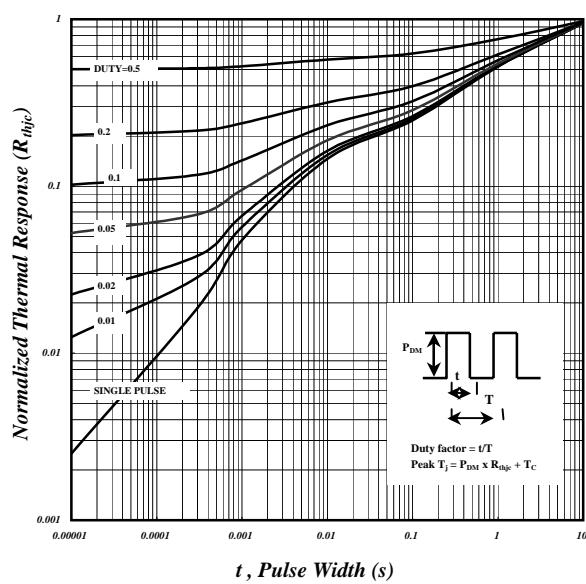
**Fig 5. Maximum Drain Current v.s.  
Case Temperature**



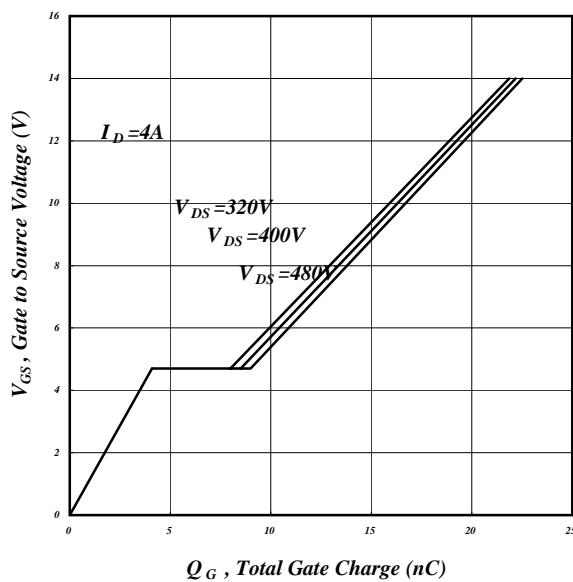
**Fig 6. Typical Power Dissipation**



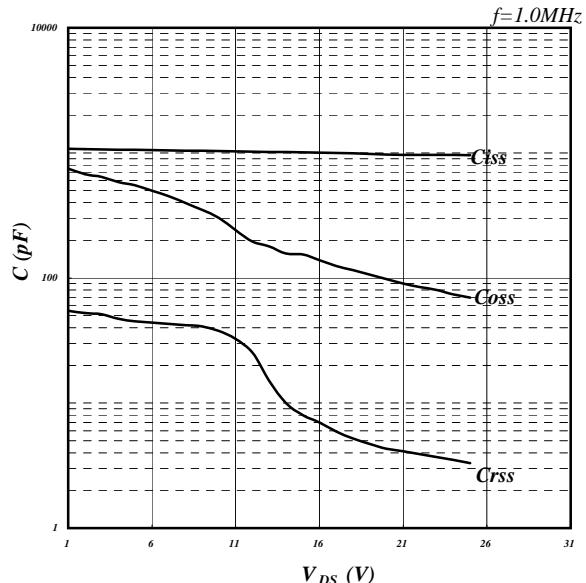
**Fig 7. Maximum Safe Operating Area**



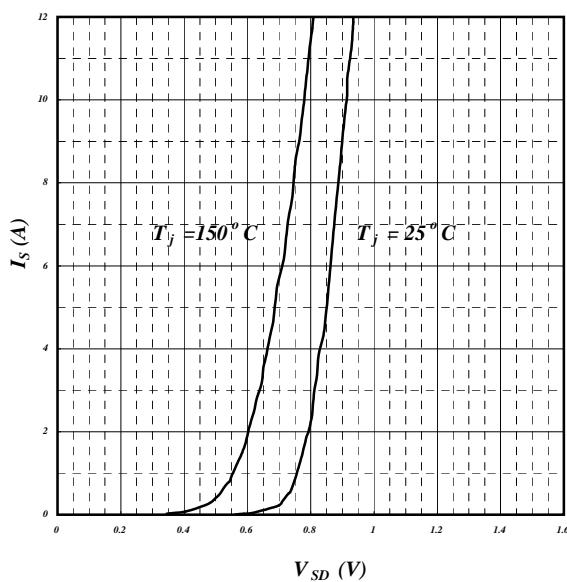
**Fig 8. Effective Transient Thermal Impedance**



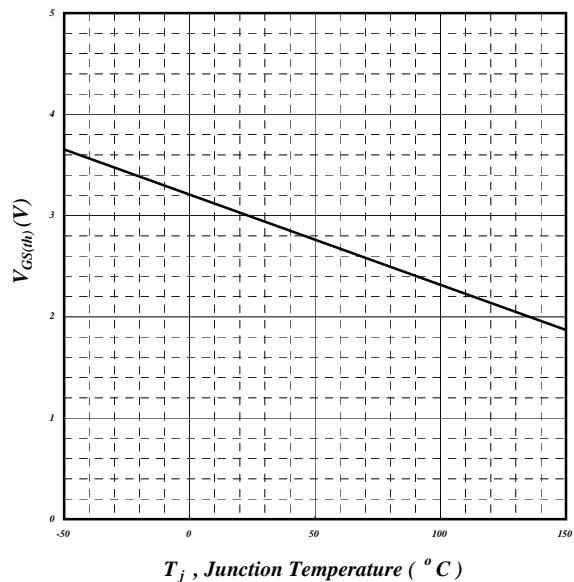
**Fig 9. Gate Charge Characteristics**



**Fig 10. Typical Capacitance Characteristics**



**Fig 11. Forward Characteristic of Reverse Diode**



**Fig 12. Gate Threshold Voltage v.s. Junction Temperature**



## AP04N70BI-H

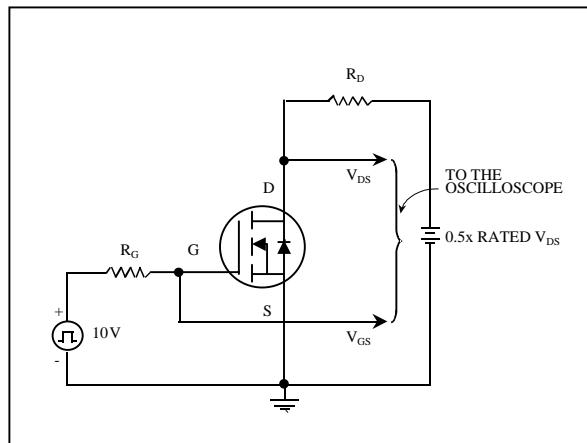


Fig 13. Switching Time Circuit

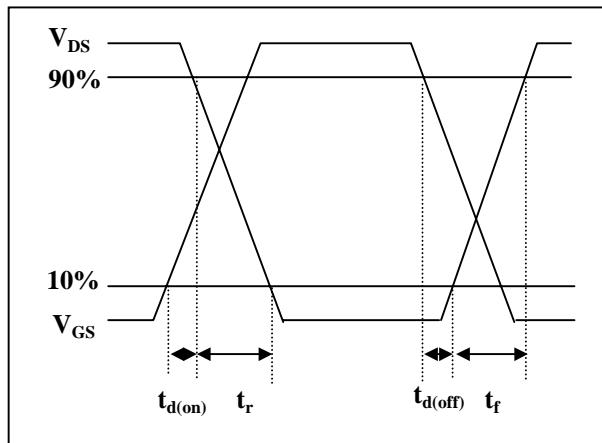


Fig 14. Switching Time Waveform

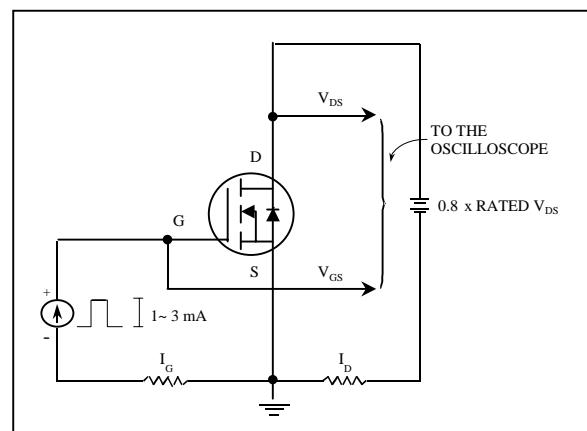


Fig 15. Gate Charge Circuit

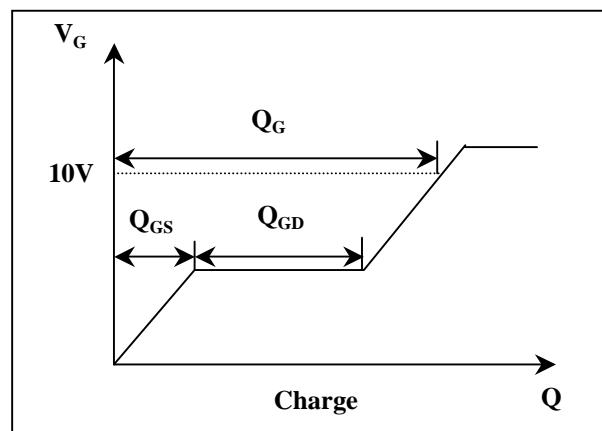


Fig 16. Gate Charge Waveform